Str 0 & 2005

1818.

**PATENT** 

## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In Re Application of

Customer Number: 20277

oug Van Den BROEKE, et al.

Confirmation Number: 4766

Application No.: 10/659,715

Group Art Unit: 2878

Filed: September 11, 2003

Examiner: LU, TONY W

For: METHOD OF ACHIEVING CD LINEARITY CONTROL FOR FULL-CHIP CPL

MANUFACTURING

## **INFORMATION DISCLOSURE STATEMENT**

Mail Stop Amendment Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Dear Sir:

In accordance with the provisions of 37 C.F.R. 1.56, 1.97 and 1.98, the attention of the Patent and Trademark Office is hereby directed to the references listed on the attached form PTO-1449. It is respectfully requested that the references be expressly considered during the prosecution of this application, and that the references be made of record therein and appear among the "References Cited" on any patent to issue therefrom.

This Information Disclosure Statement is being filed within three months of the U.S. filing date OR before the mailing date of a first Office Action on the merits. No certification or fee is required.

Each non-English language reference was first cited in a corresponding foreign application search report and its relevance discussed therein. A copy of the foreign search

## 10/659,715

r)

report, together with an English language version thereof, is attached for the Examiner's information.

Please charge any shortage in fees due in connection with the filing of this paper, including extension of time fees, to Deposit Account 500417 and please credit any excess fees to such deposit account.

Respectfully submitted,

McDERMOZP WILL & EMERY LLP

Michael E. Fogarty Registration No. 36,139

600 13<sup>th</sup> Street, N.W. Washington, DC 20005-3096 Phone: 202.756.8000 MEF:gav

Facsimile: 202.756.8087

Date: September 6, 2005

Please recognize our Customer No. 20277 as our correspondence address.

SHEET 1 OF 1

·		10	&/				N.	SHEET I	<u> </u>		
INFORMATION IN AN					ATTY. DOCKET NO. <b>055071-0283</b>		rial no. <b>D/659,715</b>				
APPLICATION											
					APPLICANT  Doug Van Den E	APPLICANT Doug Van Den BROEKE, et al.					
(PTO-1449)					FILING DATE September 11, 2	GROUP 2878					
U.S. PATENT DOCUMENTS											
EXAMINER'S INITIALS	CITE NO.	Document Number Number-Kind Code2 (if known)		Publication Dat MM-DD-YYYY		Name of Patentee or Applicant of Cited Document			Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear		
		US 5,184,021		02/02/1993	Smith	Smith					
		US 6,383,719 B1		05/07/2002	Bula et al.	Bula et al.					
		US 5,906,901		05/25/1999	Tanimoto	Tanimoto					
		US	IS 6,383,697 B1 05/07/2002 Vladimirs		Vladimirsky et	al.	<del>                                     </del>				
		US					<del>                                     </del>				
		US									
·		US									
		US							•		
	<u> </u>	US	<u> </u>	<u> </u>			<b>-</b>				
		US									
		US		<del> </del>			+	<del> </del>			
		US					<del></del>	· · ·			
		US							Α		
FOREIGN PATENT DOCUMENTS											
EXAMINER'S INITIALS	CITE NO.	Foreign Patent Document Country Codes -Number 4 -Kind Codes (if known)		Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Colu Where R Figures	elevant	Translat Yes	ion No		
	ļ	ļ									
		ļ									
		<b></b>									
OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)											
EXAMINER'S INITIALS	CITE NO.	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.									
		<b></b>				<del> </del>					
FYAMINED						DATE CONSIDERED					
EXAMINER					·	DATE CONSIDERED					

<sup>\*</sup>EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

1 Applicant's unique citation designation number (optional). 2 Applicant is to place a check mark here if English language Translation is attached.